

OptiMOS[™] Power-Transistor

Features

- Optimized for high performance SMPS, e.g. sync. rec.
- 100% avalanche tested
- Superior thermal resistance
- N-channel
- Qualified according to JEDEC¹⁾ for target applications
- · Pb-free lead plating; RoHS compliant
- Halogen-free according to IEC61249-2-21







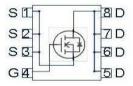
Туре	Package	Marking
BSC028N06NS	PG-TDSON-8	028N06NS

Product Summary

$V_{ m DS}$	60	V
$R_{ extsf{DS(on).max}}$	2.8	mΩ
I_{D}	100	Α
Q_{oss}	43	nC
Q _G (010V)	37	nC

PG-TDSON-8





Maximum ratings, at T_i =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	ID	V _{GS} =10 V, T _C =25 °C	100	А
		V _{GS} =10 V, T _C =100 °C	83	
		$V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C, $R_{\rm thJA}$ =50K/W ²⁾	23	
Pulsed drain current ³⁾	I _{D,pulse}	T _C =25 °C	400	
Avalanche energy, single pulse ⁴⁾	E _{AS}	$I_{\rm D} = 50 \; {\rm A}, \; R_{\rm GS} = 25 \; {\rm \Omega}$	100	mJ
Gate source voltage	V_{GS}		±20	V

¹⁾ J-STD20 and JESD22

²⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm2 (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

³⁾ See figure 3 for more detailed information

⁴⁾ See figure 13 for more detailed information



Maximum ratings, at T_i =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Power dissipation	P_{tot}	T _C =25 °C	83	W
		T _A =25 °C, R _{thJA} =50 K/W ³⁾	2.5	
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 150	°C
IEC climatic category; DIN IEC 68-1			55/150/56	

Parameter	Symbol	Conditions		Values		Unit
			min.	typ.	max.	

Thermal characteristics

Thermal resistance, junction - case	R_{thJC}	bottom	-	-	1.5	K/W
		top	-	-	20	
Device on PCB	R_{thJA}	6 cm ² cooling area ²⁾	-	-	50	

Electrical characteristics, at T_j =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{\rm GS}$ =0 V, $I_{\rm D}$ =1 mA	60	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS}=V_{\rm GS},I_{\rm D}=50~\mu{\rm A}$	2.1	2.8	3.3	
Zero gate voltage drain current	I _{DSS}	V _{DS} =60 V, V _{GS} =0 V, T _j =25 °C	1	0.5	1	μA
		V _{DS} =60 V, V _{GS} =0 V, T _j =125 °C	1	10	100	
Gate-source leakage current	I _{GSS}	$V_{\rm GS}$ =20 V, $V_{\rm DS}$ =0 V	-	10	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =10 V, I _D =50 A	-	2.5	2.8	mΩ
		V _{GS} =6 V, I _D =12.5 A	-	3.4	4.2	
Gate resistance	R _G		-	1.3	1.95	Ω
Transconductance	g_{fs}	$ V_{\rm DS} > 2 I_{\rm D} R_{\rm DS(on)max},$ $I_{\rm D} = 50~{\rm A}$	50	100	-	S



Parameter	Symbol	Symbol Conditions	Values			Unit
			min.	typ.	max.]
Dynamic characteristics						
Input capacitance	C _{iss}		2025	2700	3375	pF
Output capacitance	Coss	$V_{\rm GS}$ =0 V, $V_{\rm DS}$ =30 V, f=1 MHz	495	660	825	
Reverse transfer capacitance	C _{rss}		8.5	28	56	
Turn-on delay time	$t_{d(on)}$		-	11	22	ns
Rise time	t _r	V _{DD} =30 V, V _{GS} =10 V,	-	38	57	
Turn-off delay time	$t_{d(off)}$	$I_{\rm D}$ =50 A, $R_{\rm G,ext}$ =3 Ω	-	19	38	
Fall time	t _f		-	8	16	
Gate Charge Characteristics ⁵⁾						
Gate to source charge	Q _{gs}		9	12	16.5	nC
Gate charge at threshold	Q _{g(th)}		6	8	11	
Gate to drain charge	Q _{gd}	V _{DD} =30 V, I _D =50 A,	5	7	10.3	
Switching charge	Q _{sw}	V _{GS} =0 to 10 V	8	12	17	
Gate charge total	Qg		31	37	49	
Gate plateau voltage	V _{plateau}		4.0	4.6	5.2	V
Gate charge total, sync. FET	Q _{g(sync)}	V _{DS} =0.1 V, V _{GS} =0 to 10 V	27	33	43	nC
Output charge	Q _{oss}	V _{DD} =30 V, V _{GS} =0 V	32	43	54	
Reverse Diode						
Diode continuous forward current	Is	-7 _c =25 °C	-	-	100	А
Diode pulse current	I _{S,pulse}	7 _C =20 C	-	-	400	1
Diode forward voltage	V_{SD}	V _{GS} =0 V, I _F =50 A, T _j =25 °C	-	0.9	1.2	V
Reverse recovery time	t _{rr}	V _R =30 V, I _F =50 A,	14	35	56	ns
Reverse recovery charge	Q _{rr}	$di_F/dt=100 \text{ A/}\mu\text{s}$	14	29	58	nC

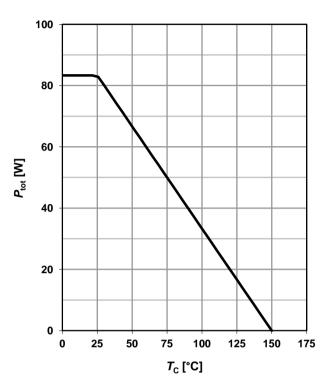
 $^{^{5)}}$ See figure 16 for gate charge parameter definition

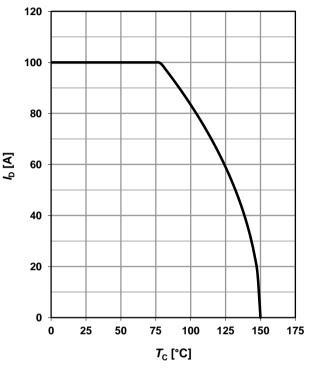


1 Power dissipation

$P_{\text{tot}} = f(T_{\text{C}})$

2 Drain current





3 Safe operating area

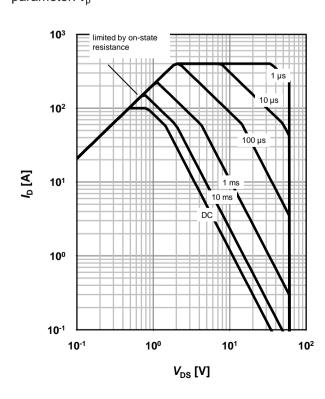
 $I_D=f(V_{DS}); T_C=25 \text{ °C}; D=0$

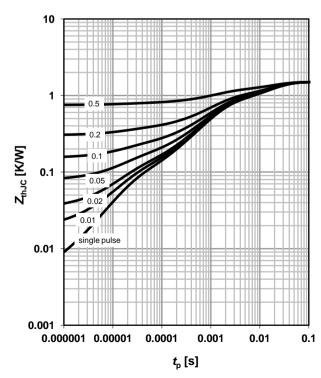
parameter: t_p

4 Max. transient thermal impedance

 Z_{thJC} =f(t_{p})

parameter: $D=t_p/T$



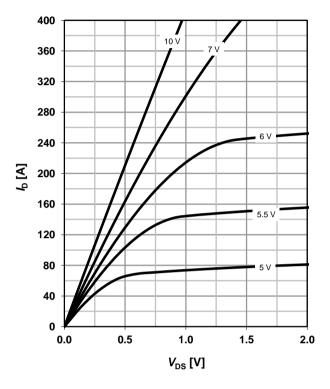




5 Typ. output characteristics

 $I_D=f(V_{DS}); T_j=25 °C$

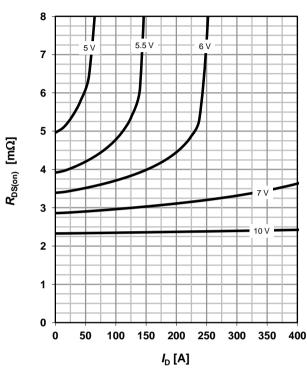
parameter: V_{GS}



6 Typ. drain-source on resistance

 $R_{DS(on)}=f(I_D); T_j=25 °C$

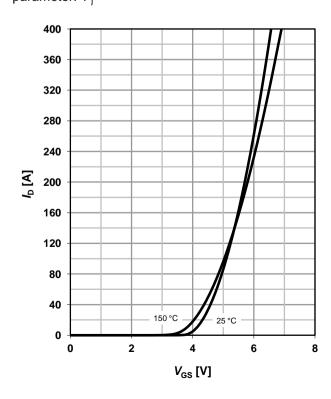
parameter: V_{GS}



7 Typ. transfer characteristics

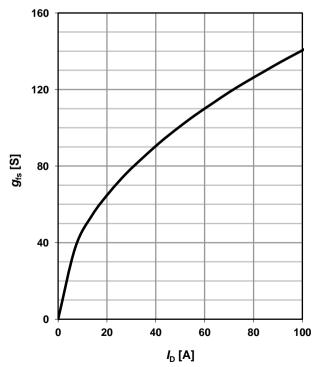
 $I_{D}=f(V_{GS}); |V_{DS}|>2|I_{D}|R_{DS(on)max}$

parameter: T_i



8 Typ. forward transconductance

 $g_{fs}=f(I_D); T_j=25 \text{ °C}$



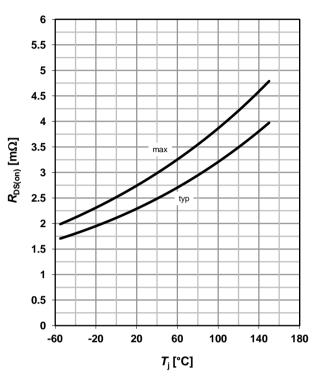


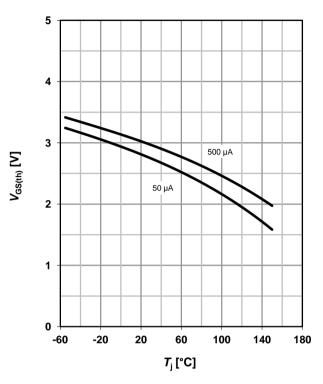
9 Drain-source on-state resistance

$R_{DS(on)} = f(T_i); I_D = 50 \text{ A}; V_{GS} = 10 \text{ V}$

10 Typ. gate threshold voltage

$$V_{GS(th)} = f(T_i); V_{GS} = V_{DS}$$





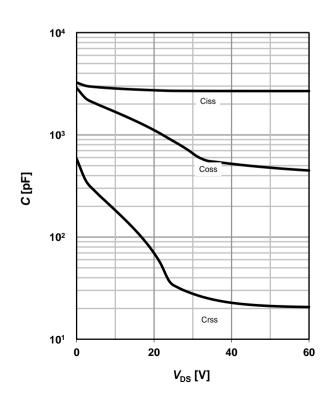
11 Typ. capacitances

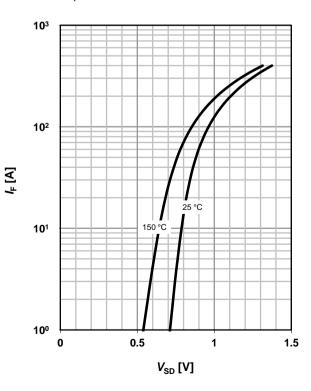
$$C=f(V_{DS}); V_{GS}=0 V; f=1 MHz$$

12 Forward characteristics of reverse diode

$$I_{\mathsf{F}} = \mathsf{f}(V_{\mathsf{SD}})$$

parameter: $T_{\rm j}$







13 Avalanche characteristics

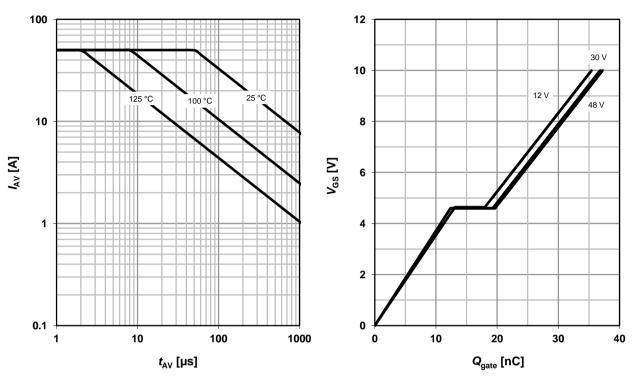
 $I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$

parameter: $T_{j(start)}$

14 Typ. gate charge

 V_{GS} =f(Q_{gate}); I_D =50 A pulsed

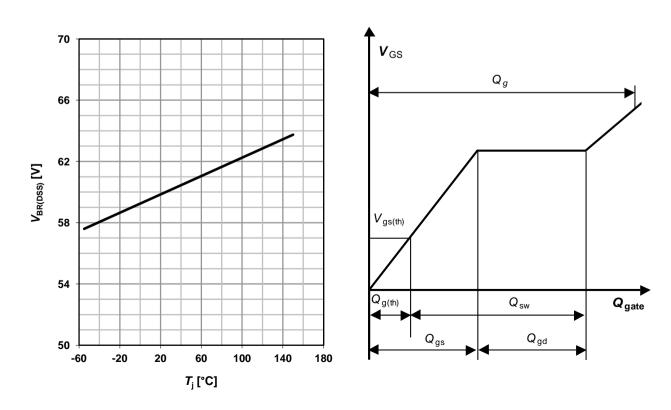
parameter: $V_{\rm DD}$



15 Drain-source breakdown voltage

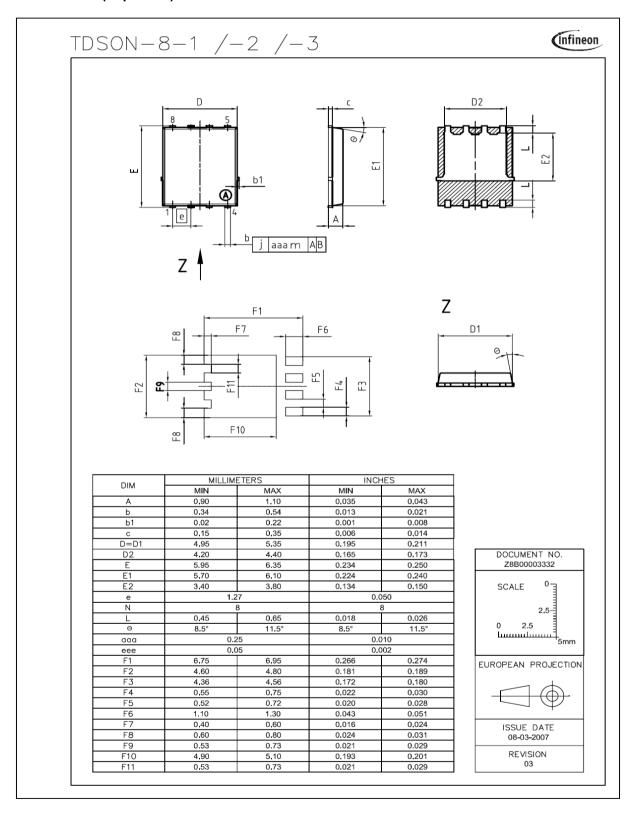
 $V_{BR(DSS)}=f(T_j); I_D=1 \text{ mA}$

16 Gate charge waveforms





PG-TDSON-8 (SuperSO8)





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